

Certificate of Conformity

The products

EUT: WLAN Broadband 802.11g AP
RouterTrade Name: SparkLANModel No.: WRTR-142; WRTR-142/XXX

This certificate that the above product complies with the essential protection requirements of R&TTE Directive 1999/5/EC

Assessment of compliance of the product with the requirements relating to the following specifications

EN 300 328 V1.6.1(2004-11) EN 301 489-01 V1.6.1 (2005-09) EN 301 489-17 V1.2.1 (2002-08)

This declaration is the responsibility or the manufacturer/importer

SparkLAN Communications, Inc. 3F, No. 246, Sec. 1, Neihu Road, Neihu (114), Taipei City, Taiwan R.O.C.

THIS DOC IS ONLY VAILD IN CONNECTION WITH TEST REPORT NUMBER: 07-08-RBF-1438-01, 07-08-RBF-143-02

MANUFACTURER/IMPORTER

TEST LABORATORY

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- 2. The testing report shall not be reproduced in full, without the written approval of ETC.

2007, 08, 30

(Surname, forename, title)
(Company stampe)

(Date)

Sign: Will Yauo Manager of EMC Testing Department II Electronics Testing Center, Taiwan

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ELECTRONICS TESTING CENTER(ETC), TAIWAN File No. : 07-08-RBF-143-02 EMC TESTING DEPARTMENT II Page: 1 / 39

EN 301 489 EMC TEST REPORT

Responsible Party	: SparkLAN Communications, Inc.
Manufacturer	: SparkLAN Communications, Inc.
Description of Product	: WLAN Broadband 802.11g AP Router
Trade Name	: SparkLAN
Model No.	: WRTR-142
Test Report File No.	: 07-08-RBF-143-02
Date Test Item Received	: Aug. 28, 2007
Date Test Campaign Completed	: Aug. 30, 2007
Date of Issue	: Aug. 30, 2007

Test Performed by

ELECTRONICS TESTING CENTER (ETC), TAIWAN

NO. 34. LIN 5. DINGFU TSUEN, LINKOU SHIANG TAIPEI COUNTY, TAIWAN, 24442, R.O.C. TEL : (02)26023052 FAX : (02)26010910 http:// www.etc.org.tw ; e-mail:r00@etc.org.tw

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Note: 1. The results of the Test Report relate only to the items tested.2. The Test Report shall not be reproduced except in full, without the written approval of ETC.

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1 TEST REPORT CERTIFICATION

Client	:	SparkLAN Communications, Inc.
Address	:	3F, No. 246, Sec. 1, Neihu Road, Neihu (114), Taipei City, Taiwan, R.O.C.
Manufacturer	:	SparkLAN Communications, Inc.
Address	:	3F, No. 246, Sec. 1, Neihu Road, Neihu (114), Taipei City, Taiwan, R.O.C.
EUT	:	WLAN Broadband 802.11g AP Router
Trade name	:	SparkLAN
Model No.	:	WRTR-142
Data also apply to	:	WRTR-142/XXX
Test specifications	:	
Emissions		EN 55022:1998/A1:2000/A2:2003 EN 61000-3-2:2000 EN 61000-3-3:1995/A1:2001
Immunity	:	EN 61000-4-2:1995/A1:1998/A2:2001 EN 61000-4-3:2002 EN 61000-4-4:1995/A1:2001 EN 61000-4-5:1995/A1:2001 EN 61000-4-6:1996/A1:2001 EN 61000-4-11:1994/A1:2001
Regulations applied	:	EN 301 489-01 V1.6.1 (2005-09) EN 301 489-17 V1.2.1 (2002-08)

The testing described in this report has been carried out to the best of our knowledge and ability, and our responsibility is limited to the exercise of reasonable care. This certification is not intended to believe the sellers from their legal and/or contractual obligations.

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Charp Tien Lu Liao) Test Engineer :

Check By :

(Charles Wang)

Approve & Authorized :

Will Yauo, Manager EMC Dept. II of ELECTRONICS TESTING CENTER, TAIWAN

Laboratory Introduction: Electronics Testing Center, Taiwan is recognized, filed and mutual recognition arrangement as following:

ISO9002 : BSMI, TüV Product Service

2 ISO/IEC 17025 : BSMI, CNLA, DGT, NVLAP, CCIBLAC, UL, Compliance

S EN45001 : TüV Rheinland, NEMKO, FIMKO, SGS

G Filing : FCC, Industry Canada, VCCI

S MRA : Australia, Hong Kong, New Zealand, Singapore, USA, Japan, Korea, China,

APLAC through CNLA

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2 GENERAL INFORMATIONS

2.1 Description of EUT:

- 1. Standard IEEE 802.11 b/g
- 2. Frequency Range: 2.40GHz~2.4835GHz
- 3. Operating Frequency / Channel: $2.412 \sim 2.472$ GHz / 13 Channels
- Modulation Technique: Orthogonal frequency division multiplexing (OFDM) Direct Sequence Spread Spectrum (CCK, DQPSK, DBPSK)
- 5. Security 64/128bit WEP WPA WPA2 802.1x and 802.1i

2.2 Related Information of EUT:

Size of EUT	:	160 x 120 x 30 mm							
Power Supply :		I/P: 230Vac 50Hz 140 mA; O/P: 12Vdc 1.0A							
Cables dedica	ted fo	r EU7	[:						-
Power Line	:	[X]	Nonshielded	[]	Shielded []	None,	Length:	1.5	m
Control Line		[]	Nonshielded	[]	Shielded [X]	None,	Length:		m
RJ-45 Line		[X]	Nonshielded	[]	Shielded []	None,	Length:	3.0	m
TEL. Line	:	[]	Nonshielded	[]	Shielded [X]	None,	Length:		m
Data Line	:	[]	Nonshielded	[]	Shielded [X]	None,	Length:		m
Cables for in	tercoi	nnecti	ng:						
S-Cable	:	[]	Nonshielded	[]	Shielded [X]	None,	Length:		m
Frequency band	:	2400)MHz~2483.5N	ИHz					
Radiated Power :		13.0dBm (Rated)						-	
Transmitter antenna source	:	Integ	gral antenna						-
Channel spacing :		5MHz							

2.3 Tested Configuration:

The EUT connected with the following peripheral devices.

Product	Manufacturer	Model No.	I/O Cable
WLAN	SparkLAN	WRTR-142	1.5m Unshielded AC Adaptor Power Cord
Broadband	Communications,		3.0m Unshielded RJ-45 Cable *4
802.11g AP	Inc.		
Router *			

Remark "*" means equipment under test.

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2.4 Deviations Record:

No deviations were required.

2.5 Modification Record:

No modifications were required. (That is the EUT complied with the requirement as tested.)

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3 SUMMARY OF TEST RESULTS

3.1 Emissions:

3.1.1 Conducted Emissions			
[X]-PASS (Mode: Operation Mode(802.11B)-	Neutral)		
Minimum EMI Margin(QP) to the limit:	-5.1 dB	at	0.403 MHz
[X]-PASS (Mode: Operation Mode(802.11B)	-Line)		
Minimum EMI Margin(QP) to the limit:	-3.0 dB	at	0.536 MHz
[X]-PASS (Mode: Operation Mode(802.11G)-	Neutral)		
Minimum EMI Margin(QP) to the limit:	-2.5 dB	at	0.540 MHz
[X]-PASS (Mode: Operation Mode(802.11G)	-Line)		
Minimum EMI Margin(QP) to the limit:	-5.9 dB	at	0.720 MHz
3.1.2 Radiated Emissions			
[X]-PASS (Mode: Operation Mode(802.11B))			
Minimum EMI Margin to the limit:	-1.5 dB	at	199.920 MHz
[X]-PASS (Mode: Operation Mode(802.11G)))		
Minimum EMI Margin to the limit:	-1.6 dB	at	199.920 MHz

3.1.3 Harmonics Current Emissions

[X]-PASS

The harmonics current values were under the limits of the <u>class A</u> equipment of the <u>EN 61000-3-2</u>.

3.1.4 Voltage Fluctuations and Flicker

[X]-PASS

The voltage fluctuations and flicker values were under the limits of the EN 61000-3-3 requirements.

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3.2 Immunity:

3.2.1 Immunity Criteria:

The results of all of the immunity tests performed on the EUT were evaluated according to the following criteria, and according to the manufacturer's specifications for the EUT:

- **Performance criterion CT :** The performance criteria A shall apply. Tests shall be repeated with the EUT in standby mode (if applicable) to ensure that unintentional transmission does not occur. In systems using acknowledgement signals, it is recognized that an ACKnowledgement (ACK) or Not ACKnowlegdgement (NACK) transmission may occur, and steps should be taken to ensure that any transmission resulting from the application of the correctly interpreted.
- **Performance criterion TT :** The performance criteria B shall apply, except for voltage dips of 100 ms and voltage interruptions of 5000ms duration, for which performance criteria C shall apply. Tests shall be repeated with the EUT in standby mode (if applicable) to ensure that unintentional transmission does not occur. Iin systems using acknowledgement signals, it is recognized that an acknowledgement (ACK) or notacknowledgement (NACK) transmission may occur, and steps should be taken to that any transmission resulting from the application of the test is correctly interpreted.
- **Performance criterion CR:** The performance criteria A shall apply. Where the EUT is a transceiver, under no circumstances, shall the transmitter operate unintentionally during the test. In systems using acknowledgement signals, it is recognized that an ACK or NACK transmission may occur, and steps should be taken to ensure that any transmission resulting from the application of the test is correctly interpreted.
- **Performance criterion TR:** The performance criteria B shall apply, except for voltage dips of 100 ms and voltage interruptions of 5000ms duration for which performance criteria C shall apply. Where the EUT is a transceiver, under no circumstances, shall the transmitter operate unintentionally during the test. In systems using acknowledgement signals, it is recognized that an ACK or NACK transmission may occur, and steps should be taken to ensure that any transmission resulting from the application of test is correctly interpreted.

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Performance table

Criteria	During test	After test				
Α	Shall operate as intended	Shall operate as intended				
	May show degradation of performance	Shall be no degradation of performance (note 2)				
	(note 1)	Shall be no loss of function				
	Shall be no loss of function	Shall be no loss of stored data or user programmable				
	Shall be no unintentional transmissions	functions				
В	May show loss of function (one or more)	Functions shall be self-recoverable				
	May show degradation of performance	Shall operate as intended after recovering				
	(note 1)	Shall be no degradation of performance (note 2)				
	No unintentional transmissions	Shall be no loss of stored data or user programmable				
		functions				
-						
С	May be loss function (one of more)	Functions shall be recoverable by the operator				
		Shall operate as intended after recovering				
		Shall be no degradation of performance (note 2)				
Note1 : Degradation of performance during the test is understood as a degradation to a level not below a						
	minimum performance level specified by the manufacturer for the use of the apparatus as intended. In					
	some cases the specified minimum performance level may be replaced by a permissible degradation or					
	performance.					
	If the minimum performance level or the permiss	ible performance degradation is not specified by the				
	manufacturer then either of these may be derived	from the product description and documentation				
	(including leaflets and advertising) and what the	user may reasonably expect from the apparatus if				
Nata 2 ·	used as intended.	from the start is surplanets and as we descend ation haloss a				
Note2 ·	No degradation of performance of performance a	tter the test is understood as no degradation below a				
	minimum performance level specified by the mar	infacture for the use of the apparatus as intended. In				
	some cases the specified minimum performance i	level may be replaced by a permissible degradation of				
	minimum performance level or the permissible p	perating data of user retrievable data is allowed. If the				
	manufacture then either of these may be derived	from the product description and documentation				
	(including leaflets and advertising) and what the	user may reasonably expect from the apparatus if				
	used as intended	user may reasonably expect from the apparatus fr				

3.2.2 Electrostatic Discharge Immunity:

	Requirement :Criterion B (or better)
[X] applicable	[] not applicable
Requirement : Criteria	[X] TT [X] TR
-Satisfies criterion	[X] A [] B
3.2.3 RF Radiated Fields Immunity:	
-	Requirement : Criterion A

[X] applicable	[] not applicable
Requirement :Criteria	[X] CT [X] CR
-Satisfies criterion	[X] A [] B

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3.2.4 EFT/Burst Immunity:

	R	equirement :Criterion B (or better)
[X] applicable	[] not a	pplicable
Requirement :Criteria	[X] TT	[X] TR
-Satisfies criterion	[X] A	[] B

3.2.5 Surge Immunity:

[X] applicable	[]	not app	olica	ble
Requirement :Criteria	[X]	TT	[X]	TR
-Satisfies criterion	[X]	A	[]	B

3.2.6 RF Common Mode Immunity:

	R	equirement :Criterion A
[X] applicable	[] not a	pplicable
Requirement :Criteria	[X] CT	[X] CR
-Satisfies criterion	[X] A	[] B

Requirement :Criterion B (or better)

3.2.7 Voltage Interruptions and Voltage Dips Immunity:

	Requirement : Criterion C (or better)				
[X] applicable	[] not a	pplicable			
Requirement :Criteria	[X] TT	[X] TR			
-Satisfies criterion	[] A	[X] B	[] C		

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4 TEST DATA & RELATED INFORMATIONS

4.1 Emissions:

4.1.1 Conducted Emissions Test:

4.1.1.1 Conducted Emissions Test Data:

Operating Conditions of The EUT : <u>Operation Mode(802.11B)</u>

Test Date : Aug. 29, 2007

Test Specification	EN 55022:1998/A1	EN 55022:1998/A1:2000/A2:2003 (Class B)					
Equipment	Manufacturer	Model No.	Calibration Date	Next Cal. Date			
EMI Test Receiver	Rohde & Schwarz	ESCI	2006/12/25	2007/12/24			
LISN	EMCO	3825/2	2006/10/09	2007/10/08			
LISN	Rohde & Schwarz	ESH2-Z5	2006/09/13	2007/09/12			
Climatic Condition	Ambient Temperatur	re: <u>20</u> °C	Relative Humidity:	<u>65</u> %RH			
Power Supply System	AC Power : <u>230</u> Vac	AC Power : <u>230</u> Vac <u>50</u> Hz					
Test Set-up Table-top Equipment							

Test data see the next pages.

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Mode: Operation Mode(802.11B)

Q.P

52.4

43.4

47.8

45.6

43.2

43.8

Frequency

(MHz)

0.403

0.485

0.786

0.982

1.093

2.183

Meter Reading

(dBµV)

ding	Factor	Res	ult	Lin	nit	Mar	gin	
)	ractor	(dBµV)		(dBµV)		(dBµV)		
AVG	(dB)	Q.P	AVG	Q.P	AVG	Q.P	AVG	
44.2	0.3	52.7	44.5	57.8	47.8	-5.1	-3.3	

56.3

56.0

56.0

56.0

56.0

46.3

46.0

46.0

46.0

46.0

-12.6

-7.9

-10.1

-12.5

-11.7

41.7

41.6

41.7

40.5

40.3

Notes: 1) Place of measurement: EMC LAB. of the ETC

41.4

41.3

41.4

40.2

39.8

2) The EUT was placed 0.8m above reference ground plane.

0.3

0.3

0.3

0.3

0.5

3) The symbol of "----" means the Q.P. value is under the limit for AVG. so, the AVG. value doesn't need to be measured.

43.7

48.1

45.9

43.5

44.3

4) The expanded uncertainty of the conducted emission tests is 2.45 dB.



Mode: Operation Mode(802.11B)

Neutral

Neutral

-4.6

-4.4

-4.3

-5.5

-5.7

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Frequency	Meter R (dB	Reading μV)	Factor	Res (dB	ult μV)	Lin (dB	nit μV)	Mar (dB	·gin μV)
(MHz)	Q.P	AVG	(dB)	Q.P	AVG	Q.P	AVG	Q.P	AVG
0.360	52.2	44.1	0.3	52.5	44.4	58.7	48.7	-6.2	-4.3
0.536	52.7	42.4	0.3	53.0	42.7	56.0	46.0	-3.0	-3.3
0.716	48.8	41.2	0.3	49.1	41.5	56.0	46.0	-6.9	-4.5
1.437	47.6	41.2	0.4	48.0	41.6	56.0	46.0	-8.0	-4.4
1.976	46.0	40.9	0.5	46.5	41.4	56.0	46.0	-9.5	-4.6
3.046	30.1		0.6	30.7		56.0	46.0	-25.3	

Mode: Operation Mode(802.11B)

Notes: 1) Place of measurement: EMC LAB. of the ETC

2) The EUT was placed 0.8m above reference ground plane.

- 3) The symbol of "----" means the Q.P. value is under the limit for AVG. so, the AVG. value doesn't need to be measured.
- 4) The expanded uncertainty of the conducted emission tests is 2.45 dB.



Mode: Operation Mode(802.11B)

Line

Line

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Operating Conditions of The EUT : <u>Operation Mode(802.11G)</u>

Test Date : Aug. 29, 2007

Test Specification	EN 55022:1998/A1	EN 55022:1998/A1:2000/A2:2003 (Class B)						
Equipment	Manufacturer	Model No.	Calibration Date	Next Cal. Date				
EMI Test Receiver	Rohde & Schwarz	ESCI	2006/12/25	2007/12/24				
LISN	EMCO	3825/2	2006/10/09	2007/10/08				
LISN	Rohde & Schwarz	ESH2-Z5	2006/09/13	2007/09/12				
Climatic Condition	Ambient Temperatur	re: <u>20</u> °C	Relative Humidity:	65 %RH				
Power Supply System	AC Power : <u>230</u> Vac	AC Power : <u>230</u> Vac <u>50</u> Hz						
Test Set-up	Table-top Equipmen	t						

Test data see the next pages.

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Mode: Operation Mode(802.11G)

Frequency	Meter R (dB	Meter Reading (dBµV)		Res (dB	ult μV)	Lin (dB	nit μV)	Mar (dB	gin μV)
(MHz)	Q.P	AVG	(dB)	Q.P	AVG	Q.P	AVG	Q.P	AVG
0.360	52.5	44.2	0.3	52.8	44.5	58.7	48.7	-5.9	-4.2
0.501	40.2	38.9	0.3	40.5	39.2	56.0	46.0	-15.5	-6.8
0.540	53.2	44.2	0.3	53.5	44.5	56.0	46.0	-2.5	-1.5
0.720	51.4	41.2	0.3	51.7	41.5	56.0	46.0	-4.3	-4.5
0.903	43.4	40.2	0.3	43.7	40.5	56.0	46.0	-12.3	-5.5
3.058	43.6	40.3	0.6	44.2	40.9	56.0	46.0	-11.8	-5.1

Notes: 1) Place of measurement: EMC LAB. of the ETC

2) The EUT was placed 0.8m above reference ground plane.

- 3) The symbol of "----" means the Q.P. value is under the limit for AVG. so, the AVG. value doesn't need to be measured.
- 4) The expanded uncertainty of the conducted emission tests is 2.45 dB.



Mode: Operation Mode(802.11G)

Neutral

Neutral

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Mode:	Operation Mode	(802.11G)

Frequency	Meter R (dB	Meter Reading (dBµV)		Res (dB	ult μV)	Lin (dB	nit μV)	Mar (dB	r gin μV)
(MHz)	Q.P	AVG	(dB)	Q.P	AVG	Q.P	AVG	Q.P	AVG
0.364	45.2	41.2	0.3	45.5	41.5	58.6	48.6	-13.2	-7.2
0.544	44.6	38.9	0.3	44.9	39.2	56.0	46.0	-11.1	-6.8
0.720	49.8	41.2	0.3	50.1	41.5	56.0	46.0	-5.9	-4.5
1.257	44.6	40.4	0.4	45.0	40.8	56.0	46.0	-11.0	-5.2
1.437	48.8	41.4	0.4	49.2	41.8	56.0	46.0	-6.8	-4.2
1.617	48.8	41.8	0.4	49.2	42.2	56.0	46.0	-6.8	-3.8

Notes: 1) Place of measurement: EMC LAB. of the ETC

2) The EUT was placed 0.8m above reference ground plane.

- 3) The symbol of "----" means the Q.P. value is under the limit for AVG. so, the AVG. value doesn't need to be measured.
- 4) The expanded uncertainty of the conducted emission tests is 2.45 dB.



Mode: Operation Mode(802.11G)

Line

Line

ELECTRONICS TESTING CENTER(ETC), TAIWANFile No. : 07-08-RBF-143-02 EMC TESTING DEPARTMENT IIPage: 18 / 39

4.1.1.2 Conducted Emissions Test Setup Photos:





ELECTRONICS TESTING CENTER(ETC), TAIWANFile No. : 07-08-RBF-143-02 EMC TESTING DEPARTMENT IIPage: 19 / 39

4.1.2 Radiated Emissions Test:

4.1.2.1 Radiated Emissions Test Data:

Operating Conditions of The EUT : <u>Operation Mode(802.11B)</u>

Test Date : Aug. 29, 2007

Test Specification	EN 55022:1998/A1	EN 55022:1998/A1:2000/A2:2003 (Class B)						
Equipment	Manufacturer	Model No.	Calibration Date	Next Cal. Date				
Test Receiver	Rohde & Schwarz	ESCS 30	2006/12/23	2007/12/22				
Amplifier	HP	8447D	2007/05/23	2008/05/21				
Spectrum	Advantest	R3162	2007/01/20	2008/01/19				
Bi-Log Antenna	Schaffner	CBL 6111	2006/12/22	2007/12/21				
Climatic Condition	Ambient Temperatu	Ambient Temperature:20°CRelative Humidity:65%						
Power Supply System	AC Power : <u>230</u>	AC Power : <u>230</u> Vac <u>50</u> Hz						
Test Set-up	Table-top Equipmen	ıt						

Emission	Meter R	leading	CORR'd	Res	ult	t		
Freq.	(dB	μV)	Factor	$(dB \ \mu \ V/m)$		Limit (dBuV/m)	Margins (dB)	
(MHz)	HOR.	VERT.	(dB)	HOR.	HOR. VERT.			
199.920	41.8	40.8	-13.3	28.5	27.5	30.0	-1.5	
249.780	37.5	37.9	-9.2	28.3	28.7	37.0	-8.3	
323.800	42.5	39.5	-8.1	34.4	31.4	37.0	-2.6	
539.400	38.4	37.5	-3.5	34.9	34.0	37.0	-2.1	
648.600	38.3	35.4	-3.1	35.2	32.3	37.0	-1.8	
755.700	35.3	32.7	0.1	35.4	32.8	37.0	-1.6	

Notes: 1) Place of Measurement: <u>Measuring site of the ETC</u>

2) Measurement Distance: <u>10 m</u>

3) Height of table on which the EUT was placed: 0.8 m

4) Height of Receiving Antenna: <u>1 - 4 m</u>

5) Remark "----" means that the emissions level is too low to be measured.

6) The expanded uncertainty of the radiated emission tests is 3.53 dB.

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Operating Conditions of The EUT : <u>Operation Mode(802.11G)</u>

Test Date : Aug. 29, 2007

Test Specification	EN 55022:1998/A1:2000/A2:2003 (Class B)						
Equipment	Manufacturer	anufacturer Model No.		Next Cal. Date			
Test Receiver	Rohde & Schwarz	ESCS 30	2006/12/23	2007/12/22			
Amplifier	HP	8447D	2007/05/23	2008/05/21			
Spectrum	Advantest	R3162	2007/01/20	2008/01/19			
Bi-Log Antenna	Schaffner	CBL 6111	2006/12/22	2007/12/21			
Climatic Condition	Ambient Temperatur	re: <u>20</u> °C	Relative Humidity:	<u>65</u> %RH			
Power Supply System	AC Power : <u>230</u>	AC Power : <u>230</u> Vac <u>50</u> Hz					
Test Set-up	Table-top Equipmen	ıt					

Emission	Meter Reading		CORR'd	Result			
Freq.	(dB µ V)		Factor	(dB	$(dB \ \mu V/m)$		Margins (dB)
(MHz)	HOR.	VERT.	(dB)	HOR.	VERT.		
199.920	41.7	40.7	-13.3	28.4	27.4	30.0	-1.6
249.780	37.7	37.8	-9.2	28.5	28.6	37.0	-8.4
500.200	37.6	38.0	-4.2	33.4	33.8	37.0	-3.2
539.400	37.9	35.9	-3.5	34.4	32.4	37.0	-2.6
648.600	38.0	35.9	-3.1	34.9	32.8	37.0	-2.1
755.700	35.0	33.0	0.1	35.1	33.1	37.0	-1.9

Notes: 1) Place of Measurement: Measuring site of the ETC

2) Measurement Distance: 10 m

3) Height of table on which the EUT was placed: 0.8 m

4) Height of Receiving Antenna: <u>1 - 4 m</u>

5) Remark "----" means that the emissions level is too low to be measured.

6) The expanded uncertainty of the radiated emission tests is 3.53 dB.

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4.1.2.2 Radiated Emissions Test Setup Photos:





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4.1.3 Harmonics Current Emissions Test :

4.1.3.1 Harmonics Current Emissions Test Data:

Operating Conditions of The EUT : Operation Mode

Test Date : Aug. 28, 2007

Test Specification	EN 61000-3-2:2000					
Equipment	Manufacturer	Model No.	Calibration Date	Next Cal. Date		
Hormonics-1000	EMC-Partner	Hormonics-1000	2006/11/27	2007/11/26		
Climatic Condition	Ambient Temperatu	Ambient Temperature: 22 °C Relative Humidity: 49				
Power Supply System	AC Power : <u>230</u>	AC Power : <u>230</u> Vac <u>50</u> Hz				
Test Set-up	Table-top Equipmen	t				

Test data see the next pages.

ELECTRONICS TESTING CENTER(ETC), TAIWAN File No. : 07-08-RBF-143-02 EMC TESTING DEPARTMENT II Page: 23 / 39

ETC Operator : Unit : Serialnumber : Remarks : Urms = 230.3V Freq = 49.984 Range: 1A Irms = 0.083A Ipk = 0.479A cf = 5.737 P = 7.019W S = 19.23VA pf = 0.365 THDi = 93.20% THDu = 0.10% Class A Test - Time : 3min -100% Test completed, Result: PASSED

Order	Freq.	Iavg	Imax	Limit	Order	Freq.	Iavg	Imax	Limit
	[Hz]	[A]	[A]	[A]		[Hz]	[A]	[A]	[A]
1	50	0.0321	0.0322		21	1050	0.0166	0.0168	0.1071
2	100	0	0.0005	1.08	22	1100	0	0.0011	0.0836
3	150	0.0294	0.0294	2.3	23	1150	0.0147	0.0149	0.0978
4	200	0	0.0005	0.43	24	1200	0	0.001	0.0767
5	250	0.0289	0.0289	1.14	25	1250	0.0128	0.0131	0.09
6	300	0	0.0006	0.3	26	1300	0	0.001	0.0708
7	350	0.0281	0.0281	0.77	27	1350	0.0111	0.0114	0.0833
8	400	0	0.0007	0.23	28	1400	0	0.0009	0.0657
9	450	0.027	0.027	0.4	29	1450	0.0095	0.0098	0.0776
10	500	0	0.0009	0.184	30	1500	0	0.0009	0.0613
11	550	0.0256	0.0257	0.33	31	1550	0.0081	0.0084	0.0726
12	600	0	0.0009	0.1533	32	1600	0	0.0008	0.0575
13	650	0.024	0.0242	0.21	33	1650	0.0069	0.0071	0.0682
14	700	0	0.001	0.1314	34	1700	0	0.0007	0.0541
15	750	0.0223	0.0225	0.15	35	1750	0.0059	0.0061	0.0643
16	800	0	0.001	0.115	36	1800	0	0.0006	0.0511
17	850	0.0204	0.0206	0.1324	37	1850	0.0036	0.0052	0.0608
18	900	0	0.0011	0.1022	38	1900	0	0.0005	0.0484
19	950	0.0185	0.0187	0.1184	39	1950	0	0.0046	0.0577
20	1000	0	0.0011	0.092	40	2000	0	0.0005	0.046
								0.300A	
	+++++++								
		u ef						0.200A	
								0.100A	
3 3		11 13	15 17	19 21	23 25 27 29 3	1 33 3	5 37 39	1.000A	
							+	U=100%	
		A					<u></u>	 0.0A	
					\sim			0.500A	
								U=100%	
Oms				10ms			20r	ns	
Натто	nic Emissi	on - IEC 61	000-3-2,1	EN 61000-3-	2 , (EN60555-2)	~ .	Ranow	1 A	
Urms = Irms =	230.3	A P	= af =	7.019 W 0.365	THC = 0.08	2 A	V-nom: TestTime	230 V 3 min (1)	10%)
				Test comple	eted, Result: PASSEI	0			

HAR-1000 EMC-Return

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4.1.3.2 Harmonics Current Emissions Test Setup Photos :



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4.1.4 Voltage Fluctuations and Flicker Test:

4.1.4.1 Voltage Fluctuations and Flicker Test Data:

Test Date : Aug. 28, 2007

Test Specification	EN 61000-3-3:1995	/A1:2001			
Equipment	Manufacturer	Model No.	Calibration Date	Next Cal. Date	
Hormonics-1000	EMC-Partner	Hormonics-1000	2006/11/27	2007/11/26	
Climatic Condition	Ambient Temperatur	re: <u>22</u> °C	Relative Humidity: <u>49</u> %RH		
Power Supply System	AC Power : <u>230</u> Vac <u>50</u> Hz				
Test Set-up	Table-top Equipmen	t			

Operating Conditions of The EUT : Operation Mode



HAR-1000 EMC-Betuer

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4.1.4.2 Voltage Fluctuations and Flicker Test Setup Photos:



ELECTRONICS TESTING CENTER(ETC), TAIWANFile No. : 07-08-RBF-143-02 EMC TESTING DEPARTMENT IIPage: 27 / 39

4.2 Immunity:

4.2.1 Electrostatic Discharge Immunity Test :

4.2.1.1 Electrostatic Discharge Immunity Test Data:

Operating Conditions of The EUT : Operation Mode

Test Date : Aug. 28, 2007

Test Specification	EN 61000-4-2:1995/A1:1998/A2:2001					
Equipment	Manufacturer	Model No.	Calibration Date	Next Cal. Date		
Electrostatic Discharge Simulator	Noiseken	ESS2002	2006/08/28	2007/08/29		
Climatic Condition	Ambient Temperatur	re: <u>20</u> °C	Relative Humidity: <u>50</u> %RH			
	Atmospheric Pressu	re: 990 mbar				
Power Supply System	AC Power : <u>230</u> Vac	AC Power : <u>230</u> Vac <u>50</u> Hz				
Test Set-up	Table-top Equipmen	Table-top Equipment				

Energy-Storage Capacitor	: <u>15</u>	<u>)</u> pF				(Contac	t Disc	charge	Time	s :	<u>25 ti</u>	mes/e	ach co	nditio	n
Discharge Resistor	· <u>33</u>	<u>υ</u> Ω					Air	Discha	arge I	imes	•	<u>10</u> ti	mes/e	ach co	naitio	n
\ Discharge Mode			Con	tact l	Disch	arge)				Ai	r Dis	schar	rge		
\ESD Voltage	2	kV	_4	kV		kV		kV	2	kV	4	kV	8	kV		kV
\Points\Result\Polarity	+	_	+	_	+	_	+	_	+	_	+	_	+	_	+	_
VCP	A	А	А	А												
НСР	A	А	А	А												
P ₁ ~P ₁₀									А	A	A	A	А	А		
P ₁₁	A	А	А	А												

Note : <u>"---"means the test could not be carrier out.</u>

"A" means the EUT function was correct during the test.

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TEST POINTS





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4.2.1.2 Electrostatic Discharge Immunity Test Setup Photos :



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4.2.2 RF Radiated Fields Immunity Test :

4.2.2.1 **RF Radiated Fields Immunity Test Data:**

Operating Conditions of The EUT : Operation Mode

Test Date : Aug. 28, 2007

Test Specification	EN 61000-4-3:2002					
Equipment	Manufacturer	Model No.	Calibration Date	Next Cal. Date		
Antenna	AR	AT5080	N/A	N/A		
Signal Generator	Aglient	E4421B	2007/07/04	2008/07/03		
Amplifier	Ophir	5172	N/A	N/A		
Amplifier	Ophir	5127	N/A	N/A		
POWER METER	Booton	4232A	2007/07/04	2008/07/03		
Climatic Condition	Ambient Temperatu	re: <u>23</u> °C	Relative Humidity:	<u>51</u> %RH		
Power Supply System	AC Power : <u>230</u> Vac	AC Power : <u>230</u> Vac <u>50</u> Hz				
Test Set-up	Table-top Equipmen	t				





Frequency Rang	ge: <u>80</u>	MHz ~ <u>20</u>	<u>00 MHz</u>	Field S	Strength: <u>3</u> V/m	Modulati	on (AM 1kHz 80)%)
Sweep Rate $\leq 1.5 \times 10-3$ decades/sStep Size $\leq 1 \%$ of preceding frequency			cy value	Dwell time	: 2.9 s			
Frequency Range (MHz) Antenna-Polarization		n	Direction of Device		Test Result			
				front		А		
80-1000	1400-2000	Horizontal			rear		А	
00-1000					left		А	
				right		А		
					front		А	
80 1000	1400 2000		Vartical		rear		А	
80-1000	1400-2000	vertical			left		А	
					right		А	

Note : <u>"A" means the EUT function was correct during the test.</u>

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4.2.2.2 RF Radiated Fields Immunity Test Setup Photos :



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4.2.3 EFT/Burst Immunity Test :

4.2.3.1 EFT/Burst Immunity Test Data:

Operating Conditions of The EUT : Operation Mode

Test Date : Aug. 29, 2007

Test Specification	EN 61000-4-4:1995/A1:2001				
Equipment	Manufacturer	Manufacturer Model No. Calibration Date		Next Cal. Date	
EMC Immunity Tester	EMC-PARTNER	TRANSIENT-1000 2006/11/22		2007/11/21	
Climatic Condition	Ambient Temperatu	re: <u>22</u> °C	Relative Humidity: <u>49</u> %RH		
	Atmospheric Pressu	re : 990 mbar			
Power Supply System	AC Power : <u>100</u> Vac <u>60</u> Hz/ AC Power : <u>240</u> Vac <u>50</u> Hz				
Test Set-up	Table-top Equipmer	ıt			

Pulse Burst	:5/50ns :15m/300ms	Repetition Rate: <u>2.5kHz</u> above 2.0kV <u>5kHz</u> below and equal 2.0kV	Test time: <u>1</u> min/each condition		
	\Voltage\Polarity\		kV		
\Tes	st Point\Mode\Result\	+	-		
	L	А	А		
Power Line	Ν	А	А		
	L - N	А	А		
	\Voltage\Polarity\	<u>0.5</u> kV			
\Tes	st Point\Mode\Result\	+	-		
RJ-45	(WAN)	А	А		
RJ-45	5 (LAN)	А	А		

Note : <u>"A" means the EUT function was correct during the test.</u>

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4.2.3.2 EFT/Burst Immunity Test Setup Photos:



RJ-45(Clamp)



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4.2.4 Surge Immunity Test :

4.2.4.1 Surge Immunity Test Data:

Operating Conditions of The EUT : Operation Mode

Test Date : Aug. 29, 2007

Test Specification	EN 61000-4-5:1995	EN 61000-4-5:1995/A1:2001				
Equipment	Manufacturer	Manufacturer Model No.		Next Cal. Date		
EMC Immunity Tester	EMC-PARTNER	TRANSIENT-1000 2006/11/22		2007/11/21		
Climatic Condition	Ambient Temperatu	re: <u>22</u> °C	Relative Humidity: <u>49</u> %RH			
	Atmospheric Pressu	re : <u>990</u> mbar				
Power Supply System	AC Power : <u>100</u>	AC Power : <u>100</u> Vac <u>60</u> Hz/ AC Power : <u>240</u> Vac <u>50</u> Hz				
Test Set-up	Table-top Equipmen	ıt				

Waveform : 1.2/50µs(8/20µs)		Repetition rat	on rate : $\underline{60}$ sec Times : $\underline{1}$ time/each condition		ondition		
\Phase \Voltage \Mode \Polarity \Result		0°	90°	180°	270°	360°	
0.5 kV	L – N	+	А	А	А	А	А
		_	А	А	А	А	А
1.0 kV	L-N	+	А	А	А	А	А
		—	А	А	А	А	А

Note : <u>"A" means the EUT function was correct during the test.</u>

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4.2.4.2 Surge Immunity Test Setup Photos :



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4.2.5 RF Common Mode Immunity Test :

4.2.5.1 RF Common Mode Immunity Test Data:

Operating Conditions of The EUT : Operation Mode

Test Date : Aug. 29, 2007

Test Specification	EN 61000-4-6:1996	EN 61000-4-6:1996/A1:2001						
Equipment	Manufacturer	Model No.	Calibration Date	Next Cal. Date				
CS TESTER	FRANKONIA	CIT-10	2007/08/16	2008/08/14				
M2+3 CDN-KIT	FRANKONIA	M2+3	2007/08/16	2008/08/14				
SCHAFFUER	CS-CLAMP	KEMZ801	2007/08/16	2008/08/14				
Climatic Condition	Ambient Temperatur	Ambient Temperature: 23 °C Relative Humidity: 51 %RH						
Atmospheric Pressure : 990 mbar								
Power Supply System	AC Power : <u>230</u>	AC Power : <u>230</u> Vac <u>50</u> Hz						
Test Set-up	Table-top Equipmen	Table-top Equipment						

Frequency Range : 0.15 MHz ~ $\frac{8}{2}$	<u>0</u> MHz	MHz Field Strength : <u>3</u> V/m Mc		odulation (AM 1kHz 80%)	
Sweep Rate $\therefore \le 1.5 \times 10^{-3}$ decades/s	S Step Size $\therefore \le 1$ % of preceding frequency value Dwell Time \therefore			Dwell Time $\therefore 2.9$ s	
Frequency Range (MHz)	Tested Line			Test Result	
0.15~80	Power Line (M2)			А	
0.15~80	RJ-45(WAN)			А	
0.15~80	RJ-45(LAN) A			Α	

Note : <u>"A" means the EUT function was correct during the test.</u>

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4.2.5.2 RF Common Mode Immunity Test Setup Photos :





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4.2.6 Voltage Interruptions and Voltage Dips Immunity Test :

4.2.6.1 Voltage Interruptions and Voltage Dips Immunity Test Data:

Operating Conditions of The EUT : Operation Mode

Test Date : Aug. 29, 2007

Test Specification	EN 61000-4-11:1994/A1:2001					
Equipment	Manufacturer Model No.		Calibration Date	Next Cal. Date		
EMC Immunity Tester	EMC-PARTNER	TRANSIENT-1000	2006/11/22	2007/11/21		
Climatic Condition	Ambient Temperature: 22 °C		Relative Humidity: <u>49</u> %RH			
	Atmospheric Pressure : 990 mbar					
Power Supply System	AC Power : <u>230</u>	AC Power : <u>230</u> Vac <u>50</u> Hz/				
Test Set-up Table-top Equipment						

Test mode	Voltage dips	Durations (ms)	Interval(s)	Times	Phase	Result
Voltage interruptions	>95%	5000	10	12	0°/180°	В
Voltage ding in 9/11	60%	100	10	12	0°/180°	А
voltage dips in 760 _T	30%	10	10	12	0°/180°	А

Note : <u>"A" means the EUT function was correct during the test.</u>

"B" means the EUT's function was fail during the test. After test, the EUT operate as intended without operator intervention.

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4.2.6.2 Voltage Interruptions and Voltage Dips Immunity Test Setup Photos :



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CONSTRUCTION PHOTOS OF EUT

A. EUT

1. Top View of EUT



2. Front View of EUT



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CONSTRUCTION PHOTOS OF EUT

3. Side View of EUT



4. Rear View of EUT



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CONSTRUCTION PHOTOS OF EUT

5. Side View of EUT



6. Bottom View of EUT



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CONSTRUCTION PHOTOS OF EUT

7. Internal View of EUT



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CONSTRUCTION PHOTOS OF EUT

8. Component View of PCB



9. Solder View of PCB



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CONSTRUCTION PHOTOS OF EUT

B. Adapter

1. Top View of Adapter



2. Side View of Adapter

